



Pioneers in Wireless Testing and Certification

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Form 731 Confirmation Number:	TC331196
Date of Original E-mail:	04/07/2010

What is the DUT power drift?

[Please find attached updated test report with power drifts indicated on Pages 22-25.](#)

Provide probe calibration measurement uncertainty used per device operating frequency

[Please find attached updated test report with updated uncertainty. The table is valid for frequencies 835 – 2450 MHz, per the probe calibration uncertainty component.](#)

Should you have any further questions about this application, please do not hesitate to contact us.

Sincerely,


Randy Ortanez
President



Industry
Canada

Industrie
Canada

CTIA Authorized Test Lab

LAB CODE 20020221-00



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n.b. 0002



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